



# N 沟道增强型场效应晶体管 N-CHANNEL MOSFET FHP38N20W

## 主要参数 MAIN CHARACTERISTICS

ID	38A
VDSS	200V
Rdson-typ (@Vgs=10V)	52mΩ
Qg-typ	58nC

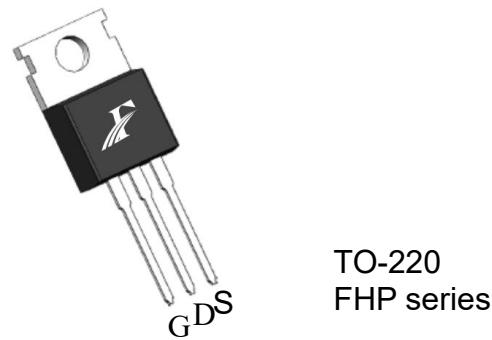
## 用途 APPLICATIONS

音响功放	Audio power amplifier
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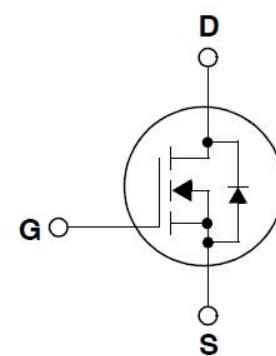
## 产品特性 FEATURES

低栅极电荷	Low gate charge
低 Crss (典型值 57pF)	Low Crss (typical 57pF )
开关速度快	Fast switching
100% 经过雪崩测试	100% avalanche tested
100% 经过热阻测试	100% DVDS tested
100% 经过 Rg 测试	100% Rg tested
高抗 dv/dt 能力	Improved dv/dt capability
RoHS 产品	RoHS product

## 封装形式 Package



## 等效电路 Equivalent Circuit



## 绝对最大额定值 ABSOLUTE RATINGS (Tc=25°C)

项目 <b>Parameter</b>	符号 <b>Symbol</b>	数值 <b>Value</b>	单位 <b>Unit</b>
		FHP38N20W	
最高漏极—源极直流电压 Drain-Source Voltage	VDS	200	V
连续漏极电流* Drain Current -continuous *	Id (Tc=25°C)	38	A
	Id (Tc=100°C)	23	A
最大脉冲漏极电流 (注 1) Drain Current – pulse (note 1)	IdM	152	A
最高栅源电压 Gate-Source Voltage	VGS	±30	V
单脉冲雪崩能量 (注 2) Single Pulsed Avalanche Energy (note 2)	EAS	550	mJ
雪崩电流 (注 1) Avalanche Current (note 1)	IAR	10.5	A
重复雪崩能量 (注 1) Repetitive Avalanche Current (note 1)	EAR	50	mJ
二极管反向恢复最大电压变化速率 (注 3) Peak Diode Recovery dv/dt (note 3)	dv/dt	5.0	V/ns
耗散功率 Power Dissipation	PD (TC=25°C)	320	W
	-Derate above 25°C	3.8	W/°C
最高结温及存储温度 Operating and Storage Temperature Range	TJ, TSTG	150, -55 to 150	°C
引线最高焊接温度 Maximum Lead Temperature for Soldering Purposes	TL	300	°C

\*漏极电流由最高结温限制

\*Drain current limited by maximum junction temperature

## 电特性 ELECTRICAL CHARACTERISTICS

项目 Parameter	符号 Symbol	测试条件 Tests conditions	最小 Min	典型 Typ	最大 Max	单位 Units	
<b>关态特性 Off -Characteristics</b>							
漏一源击穿电压 Drain-Source Voltage	$BV_{DSS}$	$I_D=250\mu A, V_{GS}=0V$	200	-	-	V	
击穿电压温度特性 Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_J$	$I_D=250\mu A$ , referenced to 25°C	-	0.22	-	V/°C	
零栅压下漏极漏电流 Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=250V, V_{GS}=0V, T_c=25^{\circ}C$	-	-	1	$\mu A$	
		$V_{DS}=200V, T_c=125^{\circ}C$	-	-	100	$\mu A$	
栅极体漏电流 Gate-body leakage current	$I_{GSS} (F/R)$	$V_{DS}=0V, V_{GS}=\pm 30V$	-	-	$\pm 100$	nA	
<b>通态特性 On-Characteristics</b>							
阈值电压 Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D=250\mu A$	2.0	-	4.0	V	
静态导通电阻 Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=26A$	-	52	58	$m\Omega$	
正向跨导 Forward Transconductance	$g_{fs}$	$V_{DS} = 15V, I_D=26A$ (note 4)	-	12	-	S	
<b>动态特性 Dynamic Characteristics</b>							
栅极电阻 Gate resistance	$R_g$	$f = 1.0MHz$	-	2	-	$\Omega$	
输入电容 Input capacitance	$C_{iss}$	$V_{DS}=25V,$ $V_{GS}=0V,$ $f=1.0MHz$	-	2410	-	pF	
输出电容 Output capacitance	$C_{oss}$		-	297	-		
反向传输电容 Reverse transfer capacitance	$C_{rss}$		-	58	-		
<b>开关特性 Switching Characteristics</b>							
延迟时间 Turn-On delay time	$t_{d(on)}$	$V_{DS}=100V,$ $I_D=26A,$ $R_g=25\Omega$ $V_{GS}=10V$ (note 4, 5)	-	18.6	-	ns	
上升时间 Turn-On rise time	$t_r$		-	3.8	-	ns	
延迟时间 Turn-Off delay time	$t_{d(off)}$		-	30.6	-	ns	
下降时间 Turn-Off Fall time	$t_f$		-	6.2	-	ns	
栅极电荷总量 Total Gate Charge	$Q_g$	$V_{DS}=160V,$ $I_D=26A,$ $V_{GS}=10V$ (note 4, 5)	-	58	-	nC	
栅一源电荷 Gate-Source charge	$Q_{gs}$		-	18	-	nC	
栅一漏电荷 Gate-Drain charge	$Q_{gd}$		-	25	-	nC	
<b>漏一源二极管特性及最大额定值 Drain-Source Diode Characteristics and Maximum Ratings</b>							
正向最大连续电流 Maximum Continuous Drain -Source Diode Forward Current	$I_s$		-	-	38	A	
正向最大脉冲电流 Maximum Pulsed Drain-Source Diode Forward Current	$I_{SM}$		-	-	152	A	
正向压降 Drain-Source Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_s=26A$	-	0.9	1.3	V	
反向恢复时间 Reverse recovery time	$t_{rr}$	$V_{GS}=0V, I_s=26A, dI_F/dt=100A/\mu s$ (note 4)	-	136	-	ns	
反向恢复电荷 Reverse recovery charge	$Q_{rr}$		-	410	-	nC	

## 热特性 THERMAL CHARACTERISTIC

项目 Parameter	符号 Symbol	FHP38N20W	单位 Unit
结到管壳的热阻 Thermal Resistance, Junction to Case	R <sub>th(j-c)</sub>	0.5	°C/W
结到环境的热阻 Thermal Resistance, Junction to Ambient	R <sub>th(j-A)</sub>	62.5	°C/W

注释:

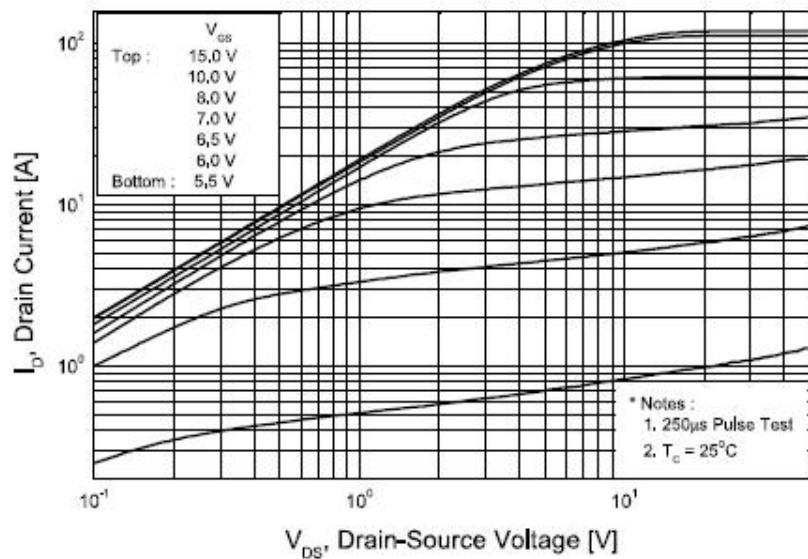
- 1: 脉冲宽度由最高结温限制
- 2: L=10mH, IAS=10.5A, VDD=50V, RG=25 Ω,起始结温 TJ=25°C
- 3: ISD ≤26A,di/dt ≤100A/μs,VDD≤BV<sub>DSS</sub>,起始结温 TJ=25°C
- 4: 脉冲测试: 脉冲宽度 ≤300μs,占空比≤2%
- 5: 基本与工作温度无关

Notes:

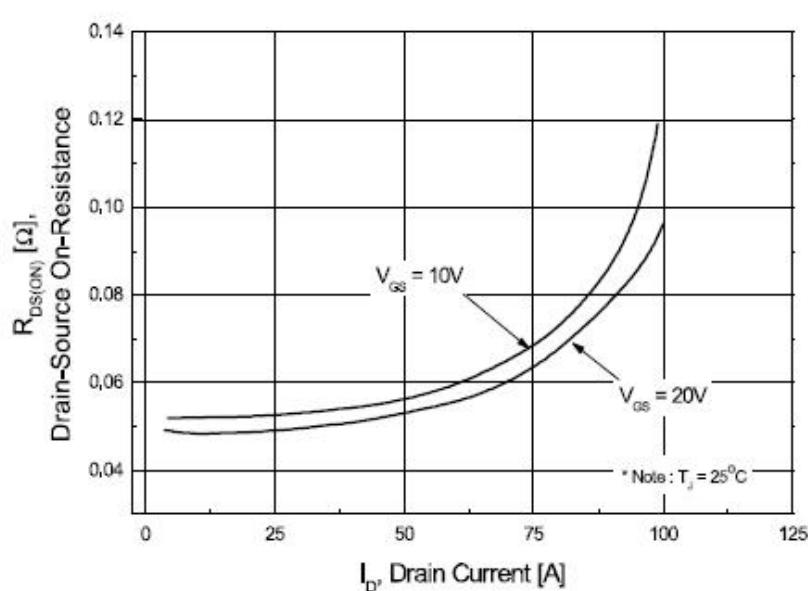
- 1: Pulse width limited by maximum junction temperature
- 2: L=10mH, IAS=10.5A, VDD=50V, RG=25 Ω ,Start TJ=25°C;
- 3: ISD ≤26A,di/dt ≤100A/μs,VDD≤BV<sub>DSS</sub>, Starting TJ=25°C
- 4: Pulse Test: Pulse Width ≤300μs,Duty Cycle≤2%
- 5: Essentially independent of operating temperature

## 特性曲线 (ELECTRICAL CHARACTERISTICS (curves))

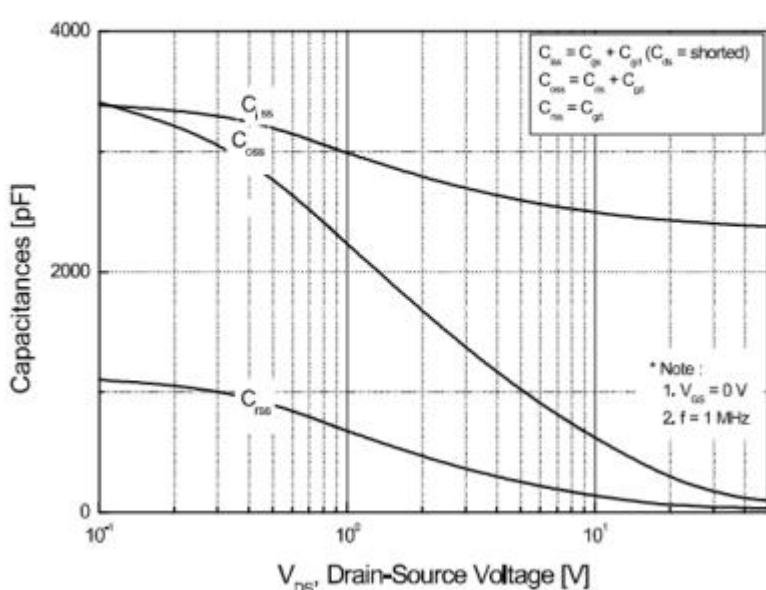
**Figure 1. On-Region Characteristics**



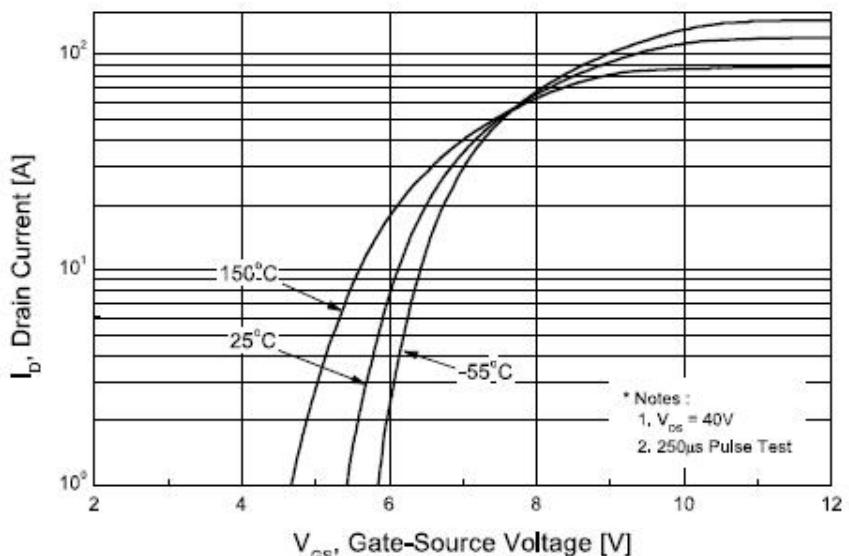
**Figure 3. On-Resistance Variation vs.  
Drain Current and Gate Voltage**



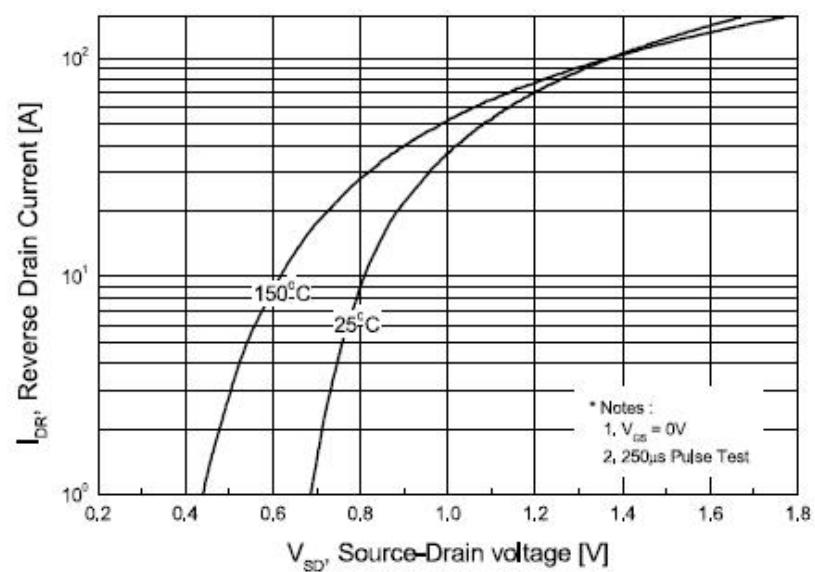
**Figure 5. Capacitance Characteristics**



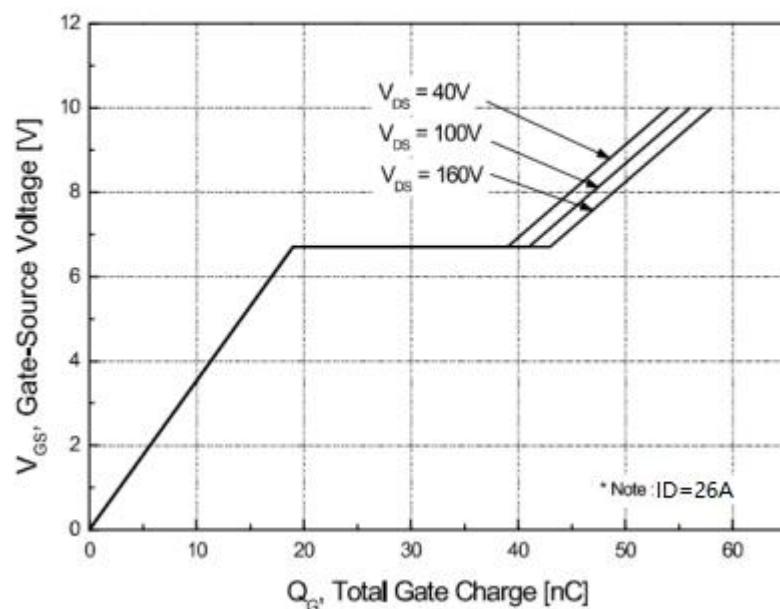
**Figure 2. Transfer Characteristics**



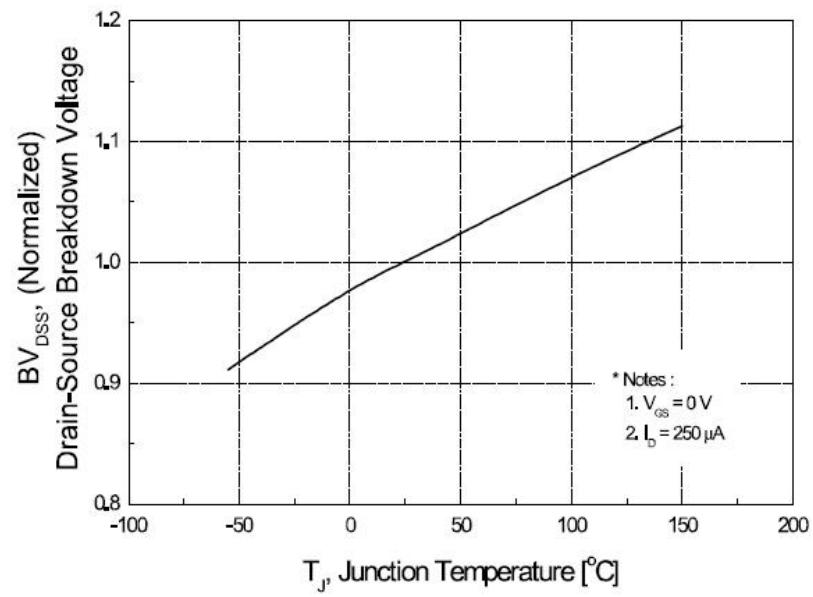
**Figure 4. Body Diode Forward Voltage  
Variation vs. Source Current  
and Temperature**



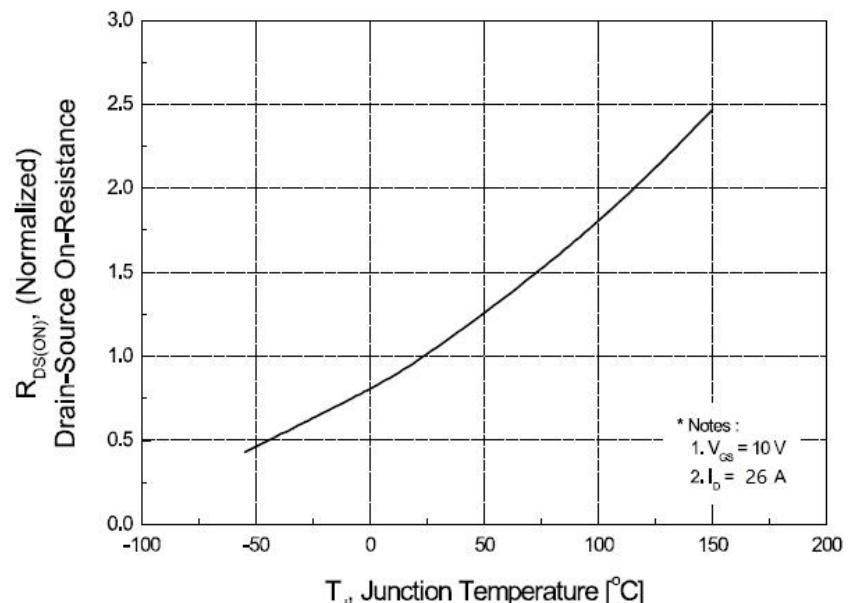
**Figure 6. Gate Charge Characteristics**



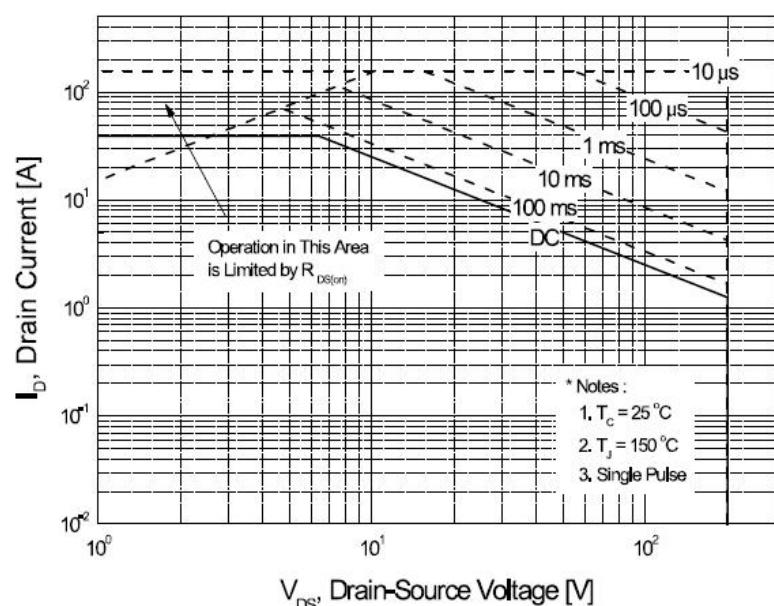
**Figure 7. Breakdown Voltage Variation vs. Temperature**



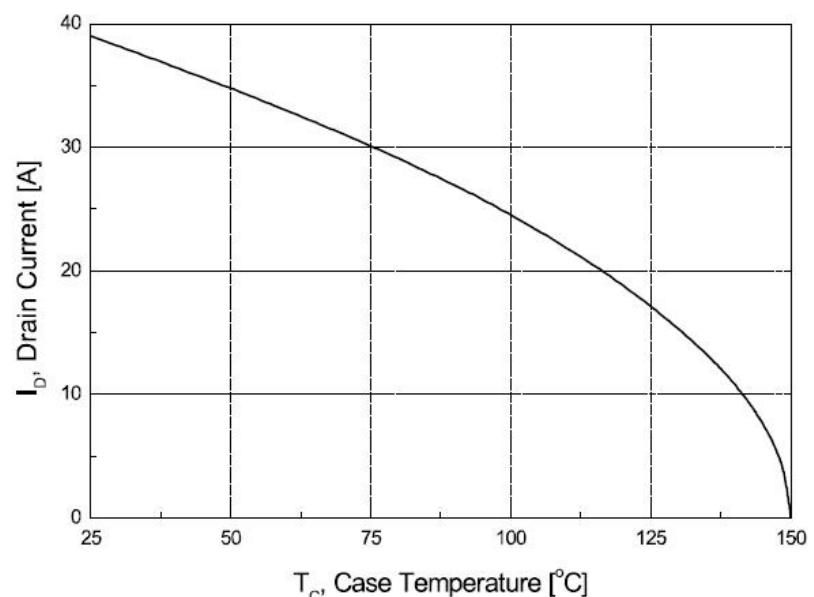
**Figure 8. On-Resistance Variation vs. Temperature**



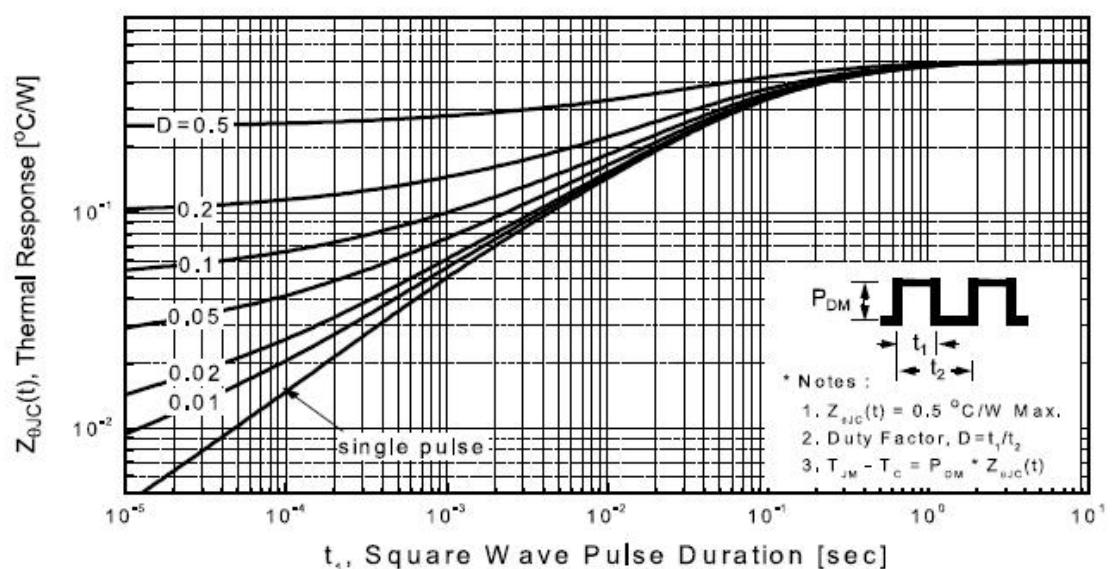
**Figure 9. Maximum Safe Operating Area**



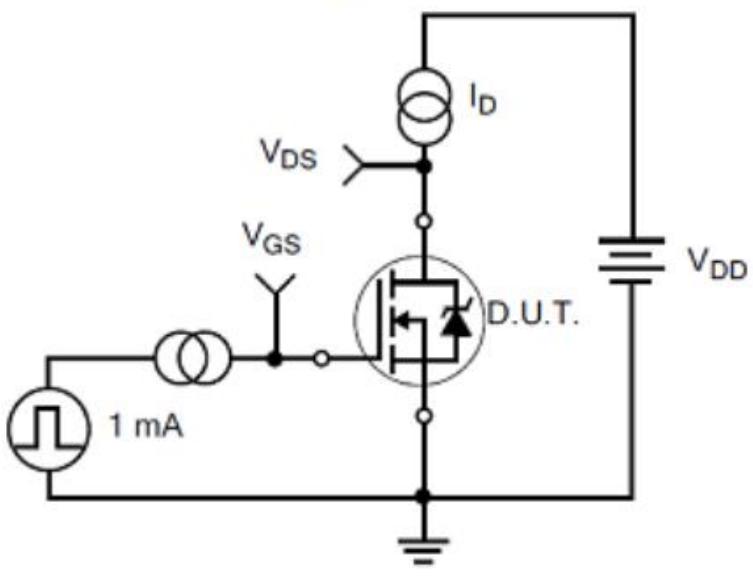
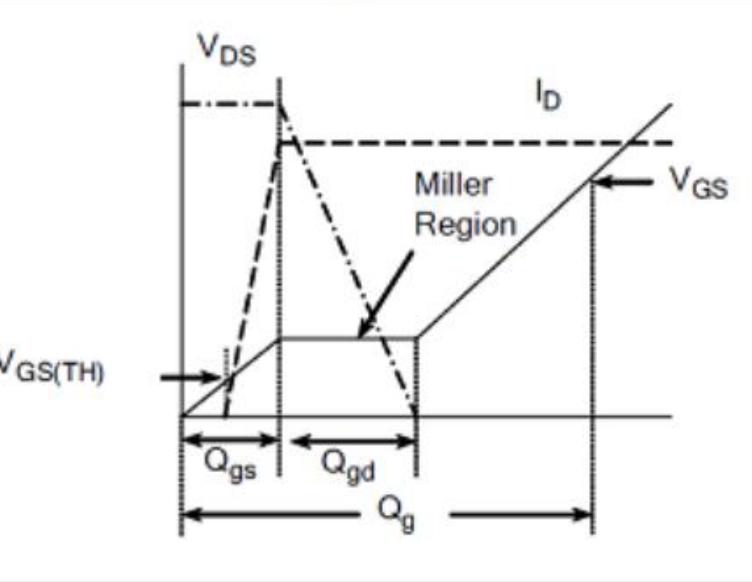
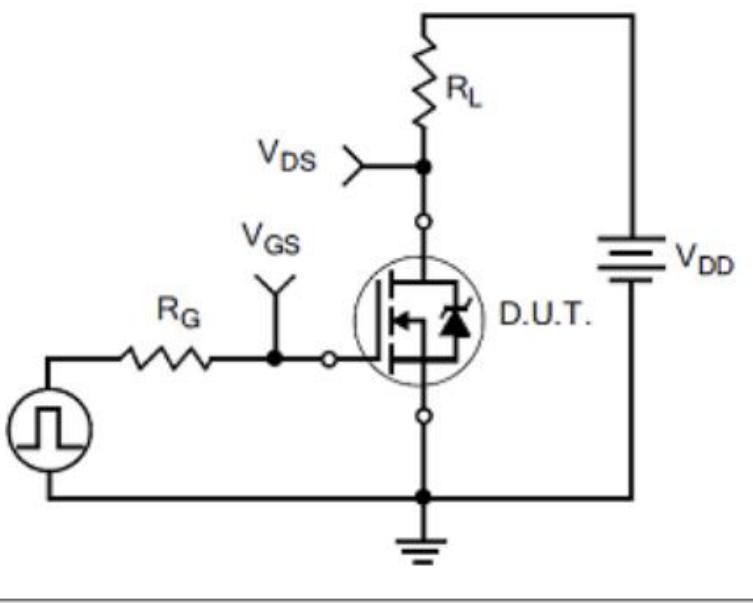
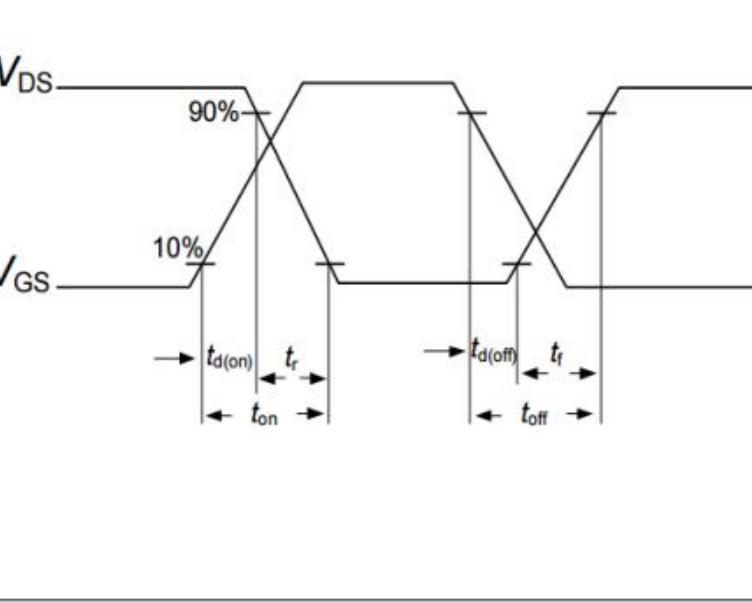
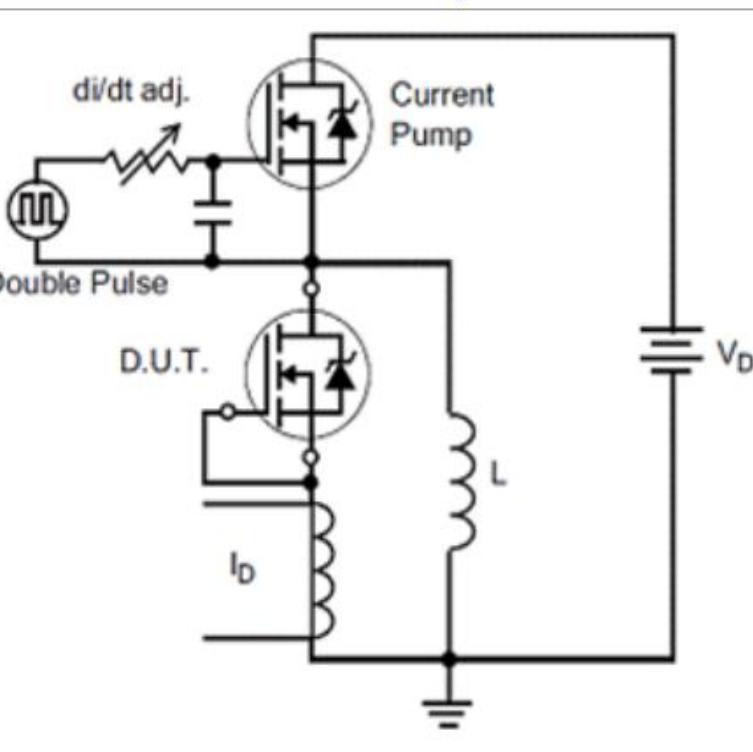
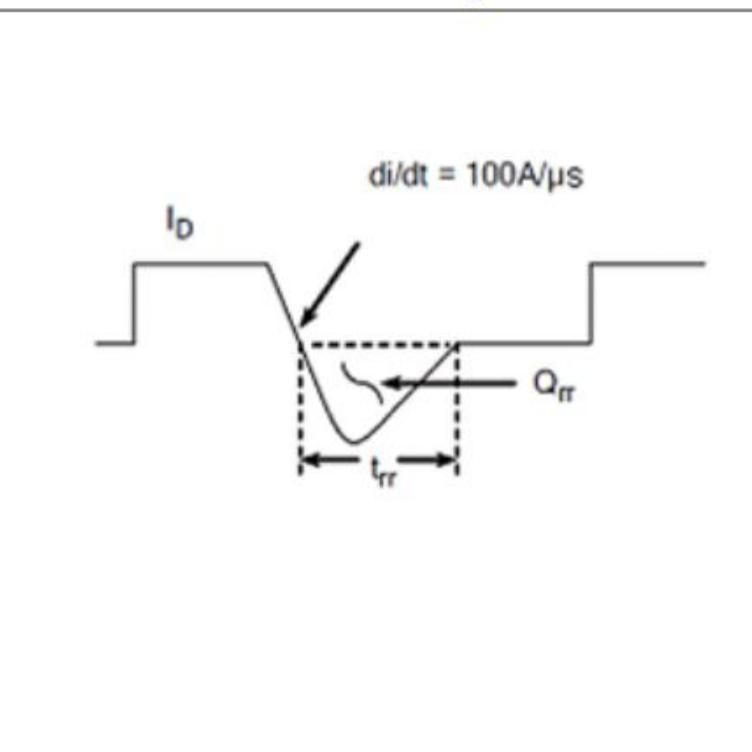
**Figure 10. Maximum Drain Current vs. Case Temperature**

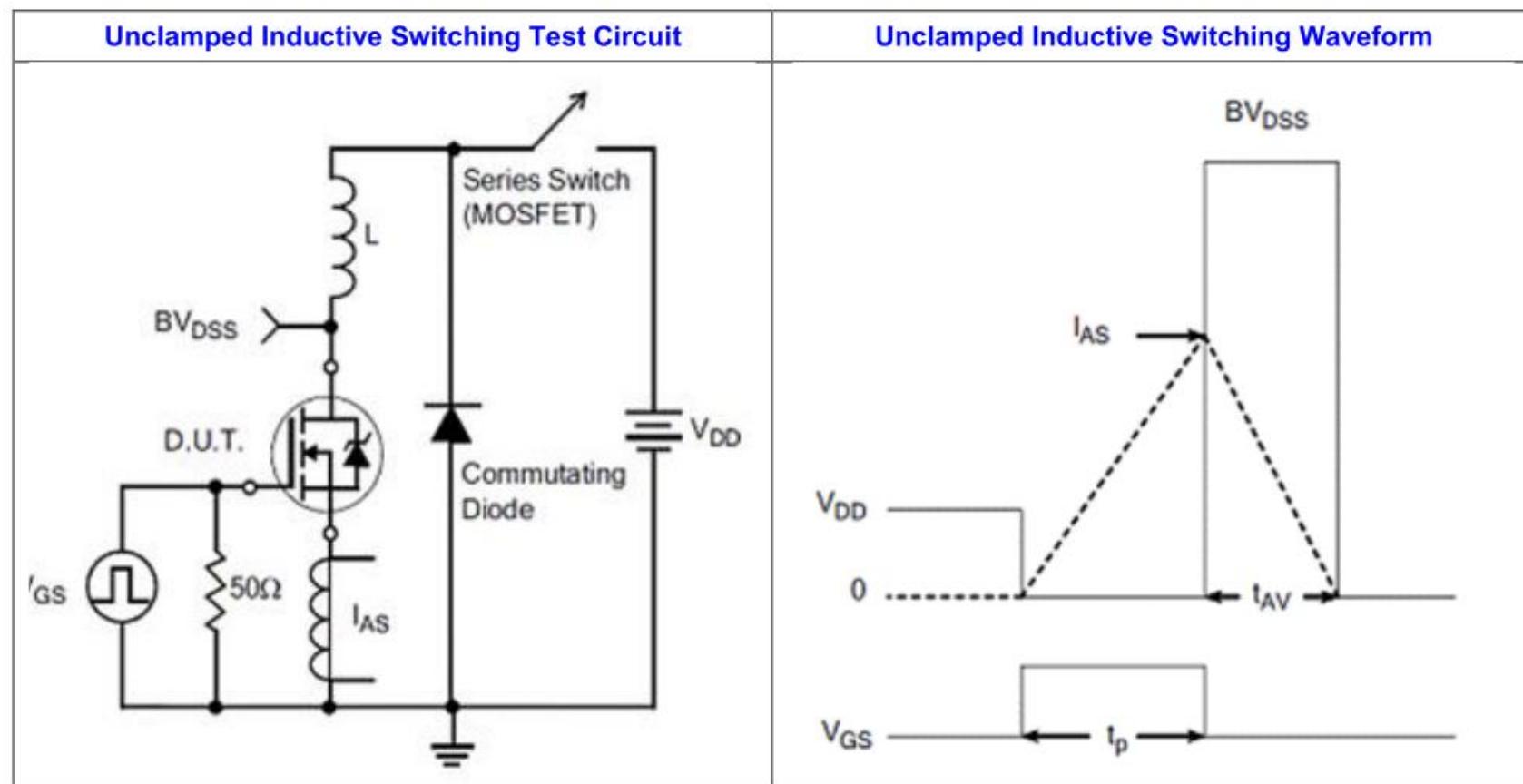


**Figure 11. Transient Thermal Response Curve**



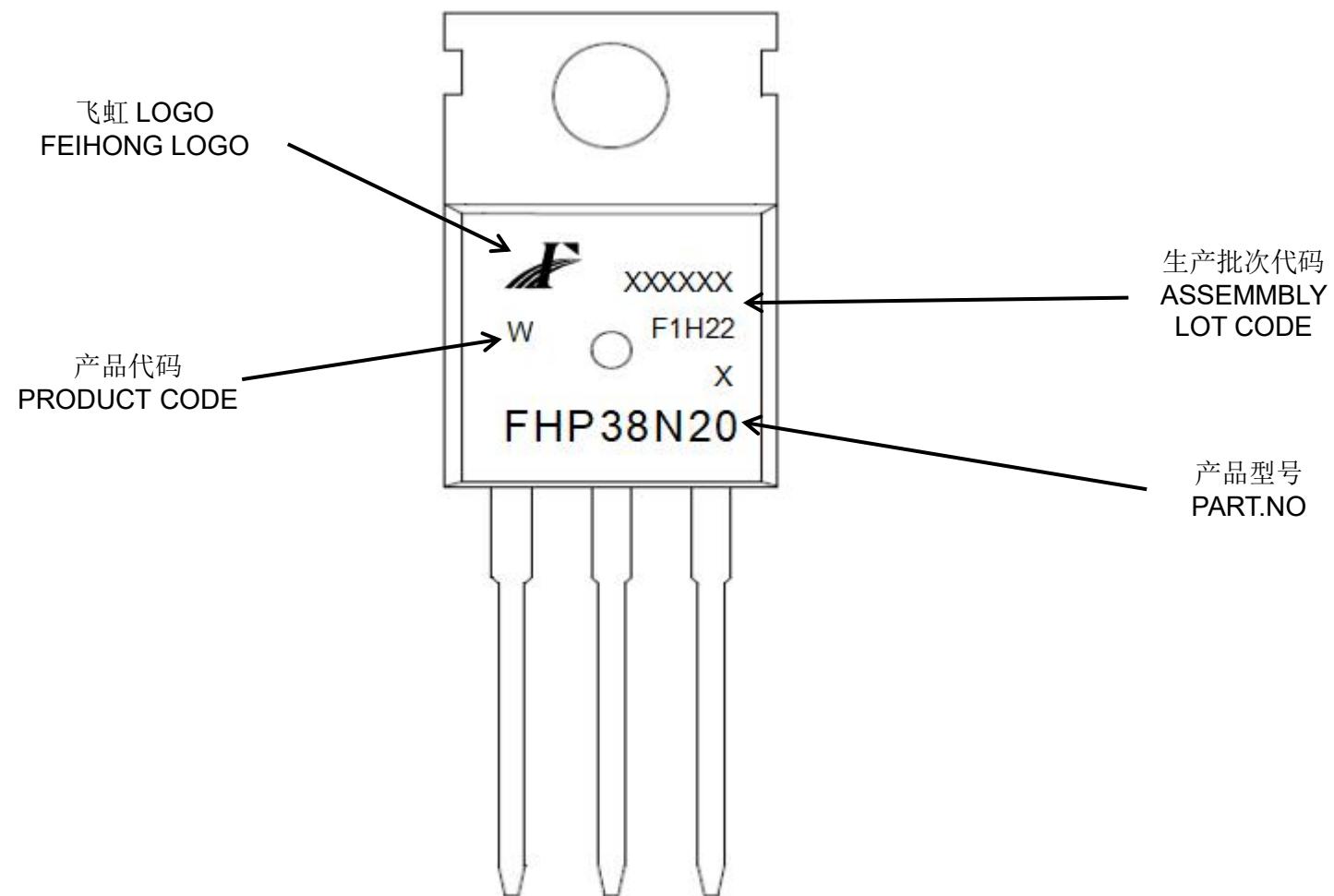
## Test Circuit and Waveform

<b>Gate Charge Test Circuit</b> 	<b>Gate Charge Waveforms</b> 
<b>Resistive Switching Test Circuit</b> 	<b>Resistive Switching Waveforms</b> 
<b>Diode Reverse Recovery Test Circuit</b> 	<b>Diode Reverse Recovery Waveform</b> 



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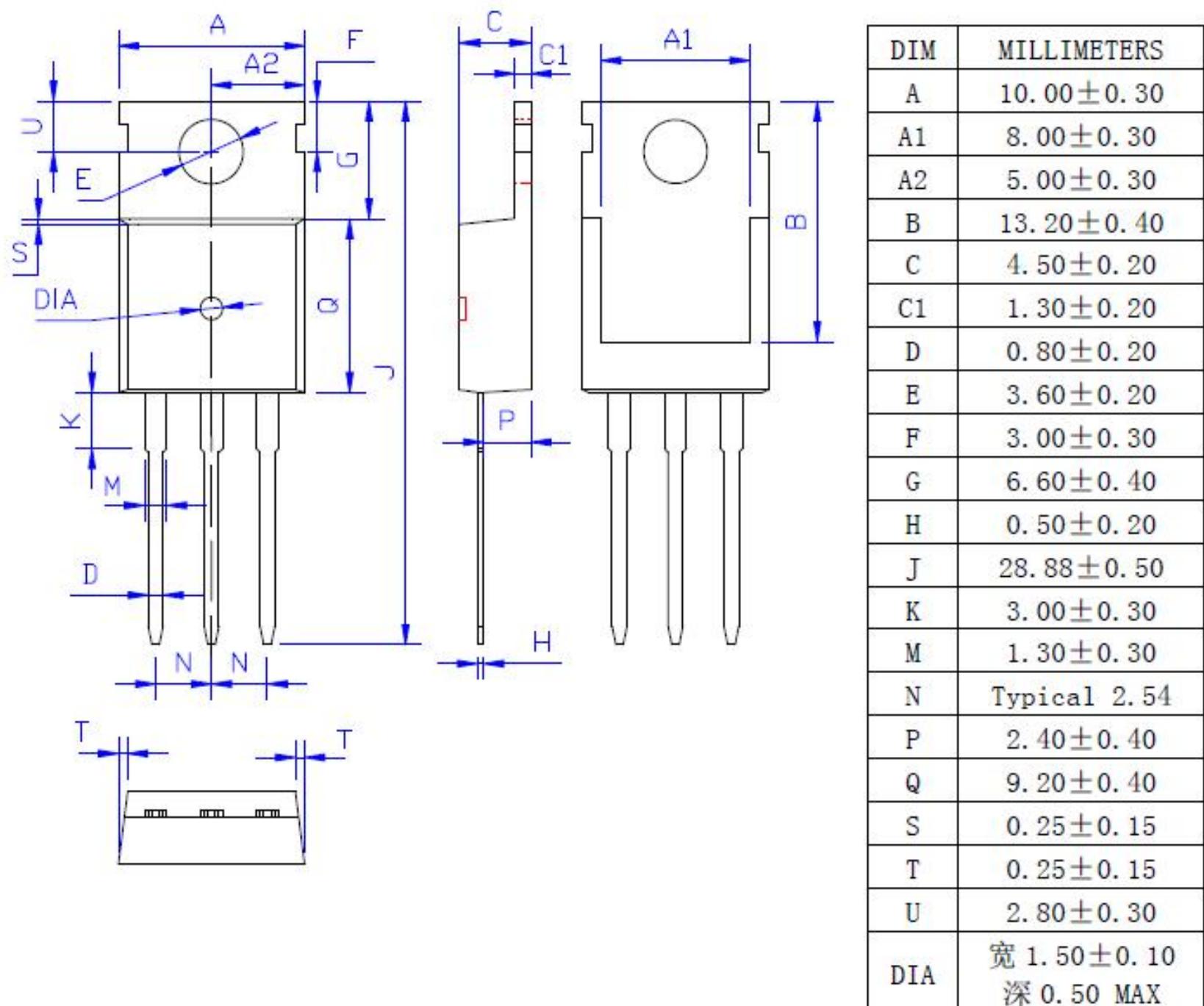
**印记 Marking:**



外形尺寸:

Package Dimension:

TO-220



(Unit: mm)